











#### TL7702B, TL7705B, TL7733B

SLVS037N - SEPTEMBER 1989-REVISED SEPTEMBER 2016

# TL7702B, TL7733B, and TL7705B Supply-Voltage Supervisors

#### **Features**

- Power-On Reset Generator
- Automatic Reset Generation After Voltage Drop
- RESET Output Defined From V<sub>CC</sub> ≥ 1 V
- Precision Voltage Sensor
- Temperature-Compensated Voltage Reference
- True and Complement Reset Outputs
- Externally Adjustable Pulse Duration

## **Applications**

- Digital Signal Processors (DSPs)
- Microcontrollers (MCUs)
- FPGAs, ASICs
- Notebooks and Desktop computers
- Set-Top Boxes
- Industrial Control Systems

## 3 Description

TL7702B. TL7705B, and TL7733B integrated-circuit supply-voltage supervisors designed for use as reset controllers in microcomputer and microprocessor supply-voltage systems. The supervisor monitors the supply for undervoltage conditions at the SENSE input. When undervoltage condition occurs during operation, outputs RESET and RESET go active.

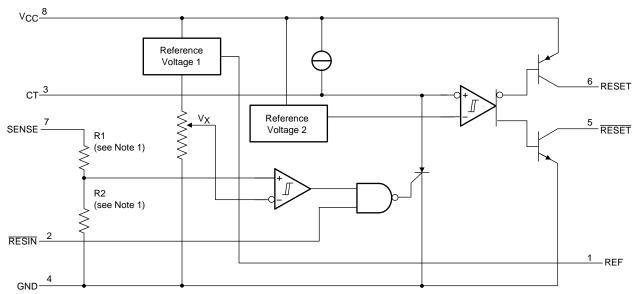
The TL7702BC, TL7705BC, and TL7733BC are characterized for operation from 0°C to 70°C. The TL7705BI, TL7702BI, and TL7733BI characterized for operation from -40°C to 85°C. The TL7705BQ is characterized for operation from -40°C to 125°C.

### Device Information<sup>(1)</sup>

PART NUMBER	PACKAGE	BODY SIZE (NOM)		
TL77xxBD	SOIC (8)	4.90 mm × 3.91 mm		
TL77xxBP	PDIP (8)	9.81 mm × 6.35 mm		

(1) For all available packages, see the orderable addendum at the end of the data sheet.

### **Functional Block Diagram**



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## 4 Revision History

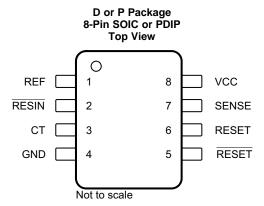
## Changes from Revision M (May 2003) to Revision N

Page

•	Added ESD Ratings table, Feature Description section, Device Functional Modes, Application and Implementation section, Power Supply Recommendations section, Layout section, Device and Documentation Support section, and Mechanical, Packaging, and Orderable Information section.
•	Deleted Ordering Information table; see POA at the end of the data sheet
•	Deleted Lead temperature row
•	Changed R <sub>BJA</sub> for D (SOIC) from 97 to 109.2 and for P (PDIP) from 85 to 51.4



## 5 Pin Configuration and Functions



**Pin Functions** 

PIN		1/0	DESCRIPTION								
NAME	NO.	1/0	DESCRIPTION								
СТ	3	0	Timing capacitor input. The timing capacitor determines the time delay that the reset outputs remain active after the voltage at the SENSE input exceeds the positive-going threshold value.								
GND	4	_	Ground								
REF	1	0	Reference voltage. See <i>Electrical Characteristics: TL77xxBC, TL77xxBI, and TL7705BQ</i> for reference voltage output and specification.								
RESET	6	0	Active high reset. See Figure 1 for RESET function and timing.								
RESET	5	0	Active low reset. See Figure 1 for RESET function and timing.								
RESIN	2	1	Reset input. When the Reset Input is low, the RESET output goes low and the RESET goes high. When the Reset Input is high, the RESET and RESET outputs are allowed to trigger based on the SENSE voltage.								
SENSE	7	I	Sense input. Voltage input to be supervised. See Figure 1 for SENSE function and timing.								
VCC	8	_	Supply voltage. See <i>Recommended Operating Conditions</i> for recommended voltage input range.								

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## 6 Specifications

#### 6.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)<sup>(1)</sup>

				MIN	MAX	UNIT
Supply voltage (2), V <sub>CC</sub>					20	V
Innut voltage V	R	ESIN		-0.3	20	V
Input voltage, V <sub>I</sub>	S	ENSE		-0.3	20	V
High-level output current, I <sub>OH</sub> (RES	RESET) –30					mA
Low-level output current, I <sub>OL</sub> (RESET)					30	mA
High-level output current, I <sub>OH</sub> (RESET)					150	°C
Storage temperature, T <sub>stg</sub>				-65	150	°C

<sup>(1)</sup> Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under Recommended Operating Conditions. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

(2) All voltage values are with respect to the network ground terminal.

### 6.2 ESD Ratings

			VALUE	UNIT
V	Flootrootatio disabarga	Human-body model (HBM), per ANSI/ESDA/JEDEC JS-001 (1)	2000	\/
V <sub>(ESD)</sub>	Electrostatic discharge	Charged-device model (CDM), per JEDEC specification JESD22-C101 (2)	1000	V

<sup>(1)</sup> JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.

### 6.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

			MIN	MAX	UNIT
V <sub>CC</sub>	Supply voltage		3.6	18	V
V <sub>IH</sub>	High-level input voltage	RESIN	2	18	V
V <sub>IL</sub>	Low-level input voltage	RESIN	0	0.8	V
VI	Input voltage	SENSE	0	18	V
I <sub>OH</sub>	High-level output current	RESET		-20	mA
I <sub>OL</sub>	Low-level output current	RESET		20	mA
		TL77xxBC	0	70	
$T_A$	Operating free-air temperature	TL77xxBI	-40	85	°C
		TL7705BQ	-40	125	

#### 6.4 Thermal Information

		TL77		
	THERMAL METRIC <sup>(1)(2)</sup>	D (SOIC)	P (PDIP)	UNIT
		8 PINS	8 PINS	
$R_{\theta JA}$	Junction-to-ambient thermal resistance	109.2	51.4	°C/W
$R_{\theta JC(top)}$	Junction-to-case (top) thermal resistance	56	40.6	°C/W
$R_{\theta JB}$	Junction-to-board thermal resistance	49.9	28.6	°C/W
ΨЈТ	Junction-to-top characterization parameter	11.4	17.7	°C/W
ΨЈВ	Junction-to-board characterization parameter	49.4	28.5	°C/W

For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application report.

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<sup>(2)</sup> JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

<sup>(2)</sup> Maximum power dissipation is a function of  $T_{J(max)}$ ,  $R_{\theta JA}$ , and  $T_A$ . The maximum allowable power dissipation at any allowable ambient temperature is  $P_D = (T_{J(max)} - T_A) / R_{\theta JA}$ . Operating at the absolute maximum  $T_J$  of 150°C can affect reliability.



## 6.5 Electrical Characteristics: TL77xxBC, TL77xxBI, and TL7705BQ

over operating free-air temperature range (unless otherwise noted)(1)

	PARAMETE	R	TEST CONDITIONS	MIN	TYP	MAX	UNIT		
V <sub>OH</sub>	High-level output volta	ge, RESET	I <sub>OH</sub> = -16 mA	V <sub>CC</sub> - 1.5			V		
V <sub>OL</sub>	Low-level output voltage	ge, RESET	I <sub>OL</sub> = 16 mA			0.4	V		
V <sub>REF</sub>	Reference voltage, RE	F	I <sub>ref</sub> = -500 μA, T <sub>A</sub> = 25°C	2.48	2.53	2.58	V		
		TL7702B		2.505	2.53	2.555			
V		TL7705B	T <sub>A</sub> = 25°C	4.5	4.55	4.6			
	Negative-going input	TL7733B		3.03	3.08	3.13	V		
$V_{IT-}$	threshold voltage at SENSE input	TL7702B		2.48	2.53	2.58	V		
		TL7705B	T <sub>A</sub> = full range <sup>(2)</sup>	4.45	4.55	4.65			
		TL7733B		3	3.08	3.16			
	Hysteresis, SENSE	TL7702B			10				
$V_{HYS}$		Hysteresis, SENSE $(V_{\text{IT+}} - V_{\text{IT-}})$ $V_{\text{CC}} = 3.6 \text{ V to } 18 \text{ V}$	V <sub>CC</sub> = 3.6 V to 18 V, T <sub>A</sub> = 25°C		30		mV		
	$(\mathbf{v}_{ T+} - \mathbf{v}_{ T-})$	TL7733B			10				
V <sub>RES</sub>	Power-up reset voltage	e <sup>(3)</sup>	I <sub>OL</sub> at RESET = 2 mA, T <sub>A</sub> = 25°C		10		V		
		RESIN	$V_I = 0.4 \text{ V to } V_{CC}$			-10			
l <sub>l</sub>	Input current	rrent SENSE, TL7702B $V_I = V_{REF}$ to 18 V			-0.1	-2	μA		
I <sub>OH</sub>	High-level output curre	ent, RESET	V <sub>O</sub> = 18 V, see Figure 8			50	μΑ		
l <sub>OL</sub>	Low-level output curre	nt, RESET	V <sub>O</sub> = 0 V, see Figure 7			-50	μA		
	0 1 .		V <sub>SENSE</sub> = 15 V, RESIN ≥ 2 V		1.8	3			
I <sub>CC</sub>	Supply current		Supply current		V <sub>CC</sub> = 18 V, T <sub>A</sub> = full range <sup>(2)</sup>			3.5	μΑ

- All electrical characteristics are measured with 0.1- $\mu$ F capacitors connected at REF, CT, and VCC to GND. Full range is 0°C to 70°C for the C-suffix devices, -40°C to 85°C for the I-suffix devices, and -40°C to 125°C for the Q-suffix device.
- This is the lowest voltage at which RESET becomes active.

### 6.6 Switching Characteristics: TL77xxBC, TL77xxBI, and TL7705BQ

V<sub>CC</sub> = 5 V, C<sub>T</sub> open, T<sub>A</sub> = 25°C, over operating free-air temperature range (unless otherwise noted)

	PARAMETER	FROM (INPUT)	TO (OUTPUT)	TEST CONDITIONS	MIN	TYP	MAX	UNIT
t <sub>PLH</sub>	Propagation delay time from low- level to high-level output	RESIN	RESET	See Figure 1, Figure 2, Figure 7		270	500	ns
t <sub>PHL</sub>	Propagation delay time from high-level to low-level output	RESIN	RESET	See Figure 1, Figure 2, Figure 8		270	500	ns
	RESIN See Figure 9,	See Figure 9,		150		20		
t <sub>w</sub>	Effective pulse duration	SENSE		Figure 10		100		ns
	Rise time		RESET	See Figure 7,			75	no
L <sub>r</sub>	Rise time		RESET	Figure 8, Figure 1		75	150	ns
	Fall time		RESET	See Figure 7,		150	200	2
t <sub>f</sub>	Fall time	ie –		Figure 8, Figure 1			50	ns

Product Folder Links: TL7702B TL7705B TL7733B



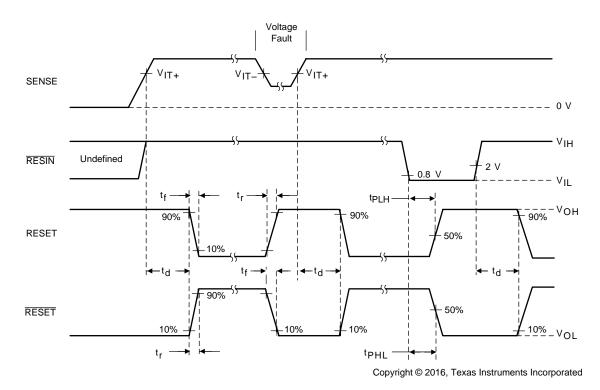


Figure 1. Timing Diagram

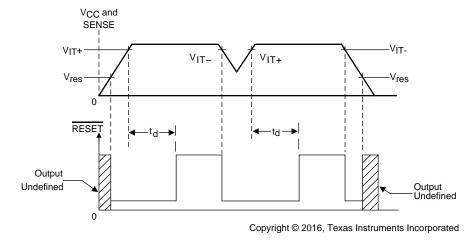
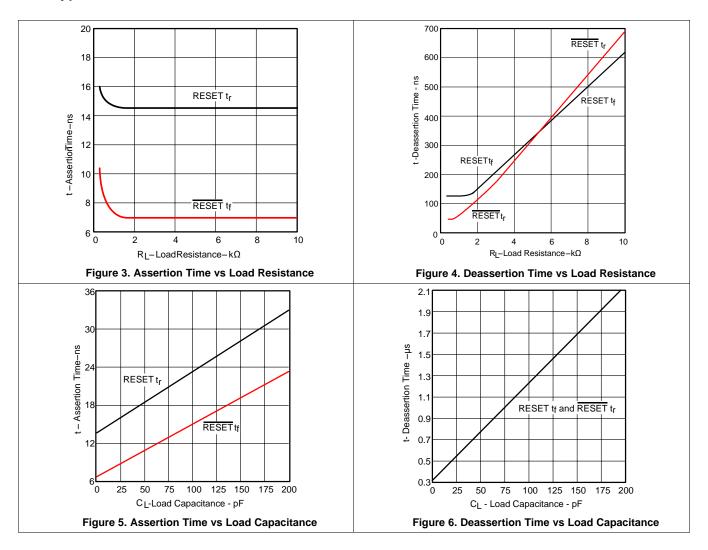


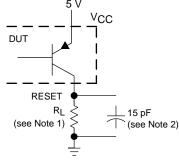
Figure 2.  $\,V_{\text{IT}}$  and  $\,V_{\text{RES}}$  Timing Diagram



## 6.7 Typical Characteristics



#### 7 Parameter Measurement Information



RESET OUTPUT CONFIGURATION

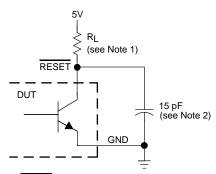
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- (1) For  $I_{OL}$  and  $I_{OH}$ ,  $R_L$  = 10 k $\Omega$ . For all switching characteristics,  $R_L$  = 511  $\Omega$ .
- (2) This figure includes jig and probe capacitance.

Figure 7. RESET Output Configuration



## **Parameter Measurement Information (continued)**



RESET OUTPUT CONFIGURATION

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- (1) For I $_{OL}$  and I $_{OH}$ , R $_{L}$  = 10 k $\Omega$ . For all switching characteristics, R $_{L}$  = 511  $\Omega$ .
- (2) This figure includes jig and probe capacitance.

Figure 8. RESET Output Configuration

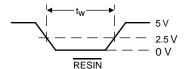


Figure 9. Input Pulse Definition RESIN

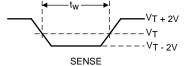


Figure 10. Input Pulse Definition SENSE



## 8 Detailed Description

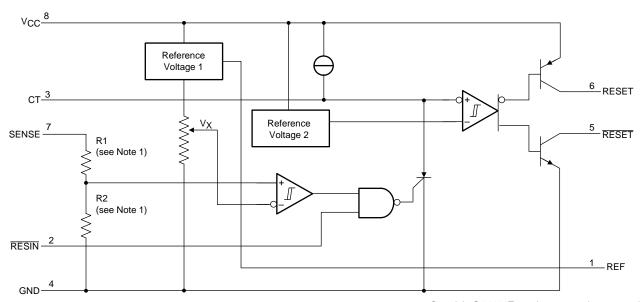
#### 8.1 Overview

The TL7702B, TL7705B, and TL7733B are integrated-circuit supply-voltage supervisors designed for use as reset controllers in microcomputer and microprocessor systems. The supply-voltage supervisor monitors the supply for undervoltage conditions at the SENSE input. During power up, the RESET output becomes active (low) when  $V_{CC}$  attains a value approaching 1 V. As  $V_{CC}$  approaches 3 V (assuming that SENSE is above  $V_{T+}$ ), the delay-timer function activates a time delay, after which outputs RESET and RESET go inactive (high and low, respectively). When an undervoltage condition occurs during normal operation, outputs RESET and RESET go active. To ensure that a complete reset occurs, the reset outputs remain active for a time delay after the voltage at the SENSE input exceeds the positive-going threshold value. The time delay is determined by the value of the external capacitor  $C_T$ :  $t_d \approx 2.6 \times 10^4 \times C_T$ , where  $C_T$  is in farads (F) and  $t_d$  is in seconds (s).

An external capacitor (typically 0.1  $\mu$ F) must be connected to REF to reduce the influence of fast transients in the supply voltage.

## 8.2 Functional Block Diagram

The functional block diagram is shown for illustrative purposes only; the actual circuit includes a trimming network to adjust the reference voltage and sense-comparator trip point.



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#### 8.3 Feature Description

### 8.3.1 Wide Supply-Voltage Range

The TL77xxB family operates using a wide supply voltage from 3.6 V to 18 V.

### 8.3.2 Adjustable Pulse Duration

The CT pin enables the ability to set a user-defined time delay in order to ensure that the fault condition is recognized. The external capacitor charges based on an internal current source until the voltage at the CT pin exceeds that of the internal reference voltage.

The time delay is determined by the value of the external capacitor  $C_T$ :  $t_d \approx 2.6 \times 10^4 \times C_T$ , where  $C_T$  is in farads (F) and  $t_d$  is in seconds (s).

The current source to charge the timing capacitor varies ±15%. Reference Voltage 2 is approximately 1.8 V and varies approximately ±5%. Once the timing capacitor charges, it discharges to about 0.6 V, not completely to 0 V.

#### 8.4 Device Functional Modes

Figure 11 displays how the RESET and RESET output pins respond to the change in the the SENSE and RESIN input pins. When the RESIN pin is high, the RESET outputs are able to respond to a drop in the supply voltage at the SENSE pin. When the RESIN pin is low, the RESET and RESET pins are set HIGH and LOW respectively.

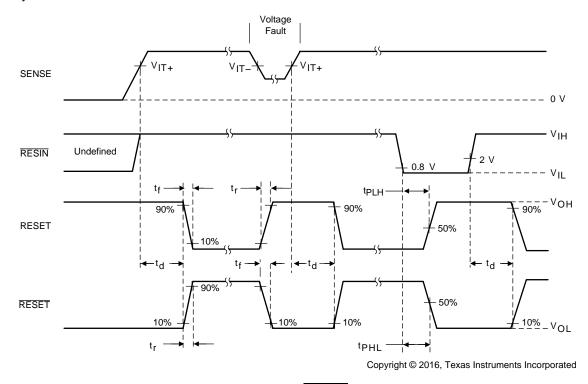


Figure 11. TL77xxB RESET and RESET Response and Timing

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## 9 Application and Implementation

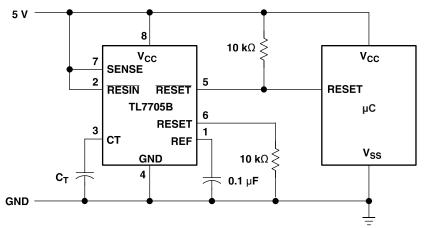
#### NOTE

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

#### 9.1 Application Information

Figure 12 shows an application where the TL7705B device is being used to sense the voltage supply for a microcontroller that is supplied with 5 V. If the voltage supply drops below the threshold voltage, the RESET pin is pulled LOW, signaling the microcontroller to reset.

### 9.2 Typical Application



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Figure 12. Reset Controller Schematic for a Microprocessor

#### 9.2.1 Design Requirements

The external components required include the decoupling capacitor for the REF pin and the timing capacitor for the CT pin. Additionally, because the RESET output is open collector, a pullup resistor is required to ensure the correct HIGH level for the microcontroller RESET pin.

### 9.2.2 Detailed Design Procedure

TI recommends pullup and pulldown resistors of 10 k $\Omega$ .

To achieve a 2.6 ms time delay, use  $C_T = 0.1 \mu F$ .

Both outputs of the TL770xB must be terminated with similar value resistors, even when only one is being used. This prevents unwanted plateauing in either output waveform during switching, which may be interpreted as an undefined state or delay system reset

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## **Typical Application (continued)**

## 9.2.3 Application Curve

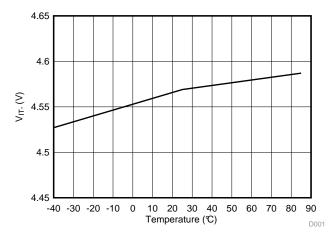


Figure 13. TL7705B Threshold Voltage vs Temperature



## 10 Power Supply Recommendations

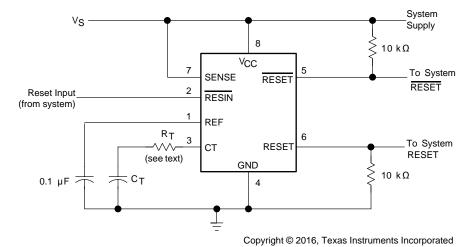


Figure 14. System Reset Controller With Undervoltage Sensing

When the TL770xB SENSE terminal is used to monitor  $V_{CC}$ , TI recommends a current-limiting resistor in series with  $C_T$ . During normal operation, the timing capacitor is charged by the onboard current source to approximately  $V_{CC}$  or an internal voltage clamp ( $\approx$ 7.1-V Zener), whichever is less. When the circuit then is subjected to an undervoltage condition during which  $V_{CC}$  is rapidly slewed down, the voltage on CT exceeds that on  $V_{CC}$ . This forward biases a secondary path internally, which falsely activates the outputs. A fault is indicated when  $V_{CC}$  drops below  $V_{(CT)}$ , not when  $V_{SENSE}$  falls below  $V_{T-}$ .

Adding the external resistor, R<sub>T</sub>, prevents false triggering. Its value is calculated as follows:

$$(V_{(CT)} - V_{T-}) / R_T$$

where

- V<sub>(CT)</sub> = V<sub>CC</sub> or 7.1 V, whichever is less
- $V_{T-} = 4.55 \text{ V (nom)}$

For 
$$V_{CC} = 5 \text{ V}$$

$$(5 - 4.55) / R_T < 1 \text{ mA}$$
 (2)

Therefore,

$$R_{T} > 450 \Omega \tag{3}$$

Using a 20%-tolerance resistor,  $R_T$  should be greater than 560  $\Omega$ .

Adding this series resistor changes the duration of the reset pulse by no more than 10%.  $R_T$  extends the discharge of  $C_T$ , but also skews the  $V_{(CT)}$  threshold. These effects tend to cancel one another. The precise percentage change can be derived theoretically, but the equation is complicated by this interaction and is dependent upon the duration of the supply-voltage fault condition.

Both outputs of the TL770xB must be terminated with similar value resistors, even when only one is being used. This prevents unwanted plateauing in either output waveform during switching, which may be interpreted as an undefined state or delay system reset.



## 11 Layout

## 11.1 Layout Guidelines

Figure 15 shows an example layout for the TL7705B device. As the RESET and RESET pins are open collector outputs, place pullup and pulldown resistors on the RESET and RESET pins respectively. A capacitor must be placed on the REF pin to stabilize the reference. This can help to prevent false triggering if noise couples into the reference.

### 11.2 Layout Example

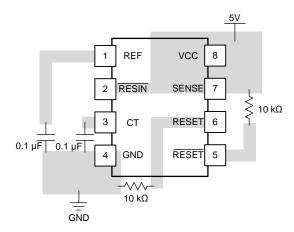


Figure 15. TL7705B Layout Example

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## 12 Device and Documentation Support

#### 12.1 Related Links

The table below lists quick access links. Categories include technical documents, support and community resources, tools and software, and quick access to sample or buy.

Table 1. Related Links

PARTS	PRODUCT FOLDER	SAMPLE & BUY	TECHNICAL DOCUMENTS	TOOLS & SOFTWARE	SUPPORT & COMMUNITY
TL7702B	Click here	Click here	Click here	Click here	Click here
TL7705B	Click here	Click here	Click here	Click here	Click here
TL7733B	Click here	Click here	Click here	Click here	Click here

## 12.2 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. In the upper right corner, click on Alert me to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

#### 12.3 Community Resources

The following links connect to TI community resources. Linked contents are provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's Terms of

TI E2E™ Online Community TI's Engineer-to-Engineer (E2E) Community. Created to foster collaboration among engineers. At e2e.ti.com, you can ask questions, share knowledge, explore ideas and help solve problems with fellow engineers.

Design Support TI's Design Support Quickly find helpful E2E forums along with design support tools and contact information for technical support.

#### 12.4 Trademarks

E2E is a trademark of Texas Instruments.

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All other trademarks are the property of their respective owners.

#### 12.5 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

## 12.6 Glossary

SLYZ022 — TI Glossarv.

This glossary lists and explains terms, acronyms, and definitions.

## 13 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.





24-Aug-2018

### **PACKAGING INFORMATION**

Orderable Device	Status	Package Type	Package Drawing	Pins	Package Qty	Eco Plan	Lead/Ball Finish (6)	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
TL7702BCD	ACTIVE	SOIC	D	8	75	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	0 to 70	7702BC	Samples
TL7702BCDR	ACTIVE	SOIC	D	8	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	0 to 70	7702BC	Samples
TL7702BCDRE4	ACTIVE	SOIC	D	8	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	0 to 70	7702BC	Samples
TL7702BCDRG4	ACTIVE	SOIC	D	8	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	0 to 70	7702BC	Samples
TL7702BCP	ACTIVE	PDIP	Р	8	50	Green (RoHS & no Sb/Br)	CU NIPDAU	N / A for Pkg Type	0 to 70	TL7702BCP	Samples
TL7702BCPE4	ACTIVE	PDIP	Р	8	50	Green (RoHS & no Sb/Br)	CU NIPDAU	N / A for Pkg Type	0 to 70	TL7702BCP	Samples
TL7702BID	ACTIVE	SOIC	D	8	75	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	7702BI	Samples
TL7702BIDR	ACTIVE	SOIC	D	8	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	7702BI	Samples
TL7702BIP	ACTIVE	PDIP	Р	8	50	Green (RoHS & no Sb/Br)	CU NIPDAU	N / A for Pkg Type	-40 to 85	TL7702BIP	Samples
TL7705BCD	ACTIVE	SOIC	D	8	75	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR	0 to 70	7705BC	Samples
TL7705BCDR	ACTIVE	SOIC	D	8	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR	0 to 70	7705BC	Samples
TL7705BCDRE4	ACTIVE	SOIC	D	8	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR	0 to 70	7705BC	Samples
TL7705BCDRG4	ACTIVE	SOIC	D	8	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR	0 to 70	7705BC	Samples
TL7705BCP	ACTIVE	PDIP	Р	8	50	Green (RoHS & no Sb/Br)	CU NIPDAU	N / A for Pkg Type	0 to 70	TL7705BCP	Samples
TL7705BID	ACTIVE	SOIC	D	8	75	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR	-40 to 85	7705BI	Samples
TL7705BIDE4	ACTIVE	SOIC	D	8	75	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR	-40 to 85	7705BI	Samples
TL7705BIDR	ACTIVE	SOIC	D	8	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR	-40 to 85	7705BI	Samples





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Orderable Device	Status	Package Type	e Package Drawing		Package Qty	Eco Plan	Lead/Ball Finish (6)	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
TL7705BIP	ACTIVE	PDIP	Р	8	50	Green (RoHS & no Sb/Br)	CU NIPDAU	N / A for Pkg Type	-40 to 85	TL7705BIP	Samples
TL7705BQD	ACTIVE	SOIC	D	8	75	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 125	7705BQ	Samples
TL7705BQDG4	ACTIVE	SOIC	D	8	75	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM		7705BQ	Sample
TL7705BQDR	ACTIVE	SOIC	D	8	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 125	7705BQ	Sample
TL7705BQDRG4	ACTIVE	SOIC	D	8	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM		7705BQ	Sample
TL7733BCD	ACTIVE	SOIC	D	8	75	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	0 to 70	7733BC	Sample
TL7733BCDE4	ACTIVE	SOIC	D	8	75	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	0 to 70	7733BC	Sample
TL7733BCDG4	ACTIVE	SOIC	D	8	75	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	0 to 70	7733BC	Sample
TL7733BCDR	ACTIVE	SOIC	D	8	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	0 to 70	7733BC	Sample
TL7733BCDRE4	ACTIVE	SOIC	D	8	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	0 to 70	7733BC	Sample
TL7733BCP	ACTIVE	PDIP	Р	8	50	Green (RoHS & no Sb/Br)	CU NIPDAU	N / A for Pkg Type	0 to 70	TL7733BCP	Sample
TL7733BID	ACTIVE	SOIC	D	8	75	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	7733BI	Sample
TL7733BIDG4	ACTIVE	SOIC	D	8	75	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	7733BI	Sample
TL7733BIDR	ACTIVE	SOIC	D	8	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	7733BI	Sample
TL7733BIP	ACTIVE	PDIP	Р	8	50	Green (RoHS & no Sb/Br)	CU NIPDAU	N / A for Pkg Type	-40 to 85	TL7733BIP	Sample

<sup>(1)</sup> The marketing status values are defined as follows: **ACTIVE:** Product device recommended for new designs.

**LIFEBUY:** TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

**PREVIEW:** Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.



## PACKAGE OPTION ADDENDUM

24-Aug-2018

(2) RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

- (3) MSL, Peak Temp. The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead/Ball Finish Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

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## **PACKAGE MATERIALS INFORMATION**

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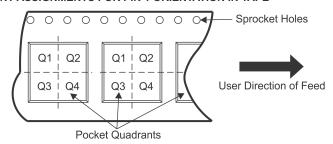
## TAPE AND REEL INFORMATION





A0	Dimension designed to accommodate the component width
	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



#### \*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
TL7702BCDR	SOIC	D	8	2500	330.0	12.4	6.4	5.2	2.1	8.0	12.0	Q1
TL7702BIDR	SOIC	D	8	2500	330.0	12.4	6.4	5.2	2.1	8.0	12.0	Q1
TL7705BCDR	SOIC	D	8	2500	330.0	12.4	6.4	5.2	2.1	8.0	12.0	Q1
TL7705BIDR	SOIC	D	8	2500	330.0	12.4	6.4	5.2	2.1	8.0	12.0	Q1
TL7705BQDR	SOIC	D	8	2500	330.0	12.4	6.4	5.2	2.1	8.0	12.0	Q1
TL7705BQDRG4	SOIC	D	8	2500	330.0	12.4	6.4	5.2	2.1	8.0	12.0	Q1
TL7733BCDR	SOIC	D	8	2500	330.0	12.4	6.4	5.2	2.1	8.0	12.0	Q1
TL7733BIDR	SOIC	D	8	2500	330.0	12.4	6.4	5.2	2.1	8.0	12.0	Q1

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\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)	
TL7702BCDR	SOIC	D	8	2500	340.5	338.1	20.6	
TL7702BIDR	SOIC	D	8	2500	340.5	338.1	20.6	
TL7705BCDR	SOIC	D	8	2500	340.5	338.1	20.6	
TL7705BIDR	SOIC	D	8	2500	340.5	338.1	20.6	
TL7705BQDR	SOIC	D	8	2500	350.0	350.0	43.0	
TL7705BQDRG4	SOIC	D	8	2500	350.0	350.0	43.0	
TL7733BCDR	SOIC	D	8	2500	340.5	338.1	20.6	
TL7733BIDR	SOIC	D	8	2500	340.5	338.1	20.6	

# D (R-PDSO-G8)

## PLASTIC SMALL OUTLINE



NOTES:

- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.006 (0,15) each side.
- Body width does not include interlead flash. Interlead flash shall not exceed 0.017 (0,43) each side.
- E. Reference JEDEC MS-012 variation AA.





SMALL OUTLINE INTEGRATED CIRCUIT



### NOTES:

- 1. Linear dimensions are in inches [millimeters]. Dimensions in parenthesis are for reference only. Controlling dimensions are in inches. Dimensioning and tolerancing per ASME Y14.5M.
- 2. This drawing is subject to change without notice.
- 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed .006 [0.15] per side.
- 4. This dimension does not include interlead flash.
- 5. Reference JEDEC registration MS-012, variation AA.



SMALL OUTLINE INTEGRATED CIRCUIT



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



SMALL OUTLINE INTEGRATED CIRCUIT



NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



# P (R-PDIP-T8)

## PLASTIC DUAL-IN-LINE PACKAGE



NOTES:

- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- C. Falls within JEDEC MS-001 variation BA.



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